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Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of Information unless it contains a valid OMB control number. Complete if Known Substitute for form 1449A/PTO **Application Number** INFORMATION DISCLOSURE Filing Date NADEAU-DOSTIE, Benoit STATEMENT BY APPLICANT First Named Inventor Group Art Unit (use as many sheets as necessary) **Examiner Name** LVPAT066US Attorney Docket Number 2 Sheet

				U.S. PATENT DOCU	MENTS	
Examiner Initiats	Cite No.1	U.S. Patent I	Ocument  Kind Code <sup>2</sup> (If known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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<sup>&</sup>lt;sup>1</sup> Unique citation designation number. <sup>2</sup> See attached Kinds of U.S. Patent Documents. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the senal number of the patent document. <sup>3</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>8</sup> Applicant is to place a check mark here if English language Translation is ettached.

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		OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS	
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ider the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number. Please type a plus sign (+) inside this box -Complete if Known Substitute for form 1449B/PTO 10/690,594 Application Number INFORMATION DISCLOSURE October 23, 2003 Filing Date First Named Inventor NADEAU-DOSTIE Penoit STATEMENT BY APPLICANT **Group Art Unit** Examiner Name (use as many sheets as necessary) LVPAT066US of 2 Attorney Docket Number Sheet OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate) title of the litem (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-iss publisher, city and/or country where published. Cite Initials' No. SCHANGTRA ET AL, "Semiconductor Manufacturing Process Monitoring Using Built-In Self-Test for Embedded Memories", Proceedings of the International Test Conference, New York, NY NAGURA Y EX AL., Test Cost Reduction by At-Speed BISE for Embedded DRAMs", Proceedings of the International Test Conference 2001. J.C 2001. Baltimore, MD, Oct. 30 - Nov.1, 2001, New York, NY. Date Examiner Considered Signature . EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance with MPEP 609. nce and not considered. Include copy of this form with next communication to applicant. 1 Unique citation designation number. 2 Applicant is to place a check mark here if English language Translation is attached. Burden Hour Statement: This form is estimated to take 2.0 hours to complete. Time will vary depending upon the needs of the individual case. Any commits on the amount of time you are required to complete this form should be sent to the Chief Information Officer, U. S. Patent and Trademark Office, Washington, DC 20231. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Assistant Commissioner for Patents, Washington, DC 20231.

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